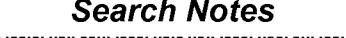


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/712,715	SUYAMA ET AL.	
Examiner	Art Unit		
FRANK W. LU	1634		

## **Search Notes**



**Application/Control No.**

10/712,715

Examiner

FRANK W. LU

**Applicant(s)/Patent under Reexamination**

SUYAMA ET AL.

## **Art Unit**

1634

## **INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner